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**Inventor Name Search Result**

Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>06633888</u>	<u>4568032</u>	150	07/24/1984	WINDING APPARATUS	ISHIDA, MASAHIRO
<u>06691908</u>	<u>4674028</u>	150	01/16/1985	IDENTIFICATION METHOD OF A PROCESS PARAMETER	ISHIDA, MASAHIRO
<u>06798025</u>	<u>4694999</u>	150	11/14/1985	TOROIDAL WINDING APPARATUS	ISHIDA, MASAHIRO
<u>06799741</u>	<u>4688733</u>	150	11/19/1985	TOROIDAL CORE WINDING APPARATUS	ISHIDA, MASAHIRO
<u>06805208</u>	<u>4691872</u>	150	12/05/1985	TOROIDAL WINDING APPARATUS	ISHIDA, MASAHIRO
<u>06888202</u>	<u>4817032</u>	150	07/23/1986	USER PROGRAMMABLE DATA PROCESSOR	ISHIDA, MASAHIRO
<u>07333587</u>	<u>4988047</u>	150	04/05/1989	WINDING APPARATUS	ISHIDA, MASAHIRO
<u>07436627</u>	Not Issued	166	11/15/1989	POLYURETHANE-UREA RESIN	ISHIDA, MASAHIRO
<u>07758207</u>	Not Issued	161	09/12/1991	POLYURETHANE-UREA RESIN	ISHIDA, MASAHIRO
<u>07875019</u>	<u>5355009</u>	150	04/28/1992	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING SAME	ISHIDA, MASAHIRO
<u>07916666</u>	<u>5319234</u>	250	07/22/1992	C-BICMOS SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>07970828</u>	Not Issued	161	11/03/1992	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING SAME	ISHIDA, MASAHIRO
<u>08037141</u>	<u>5350939</u>	150	03/25/1993	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THEREOF	ISHIDA, MASAHIRO
<u>08260428</u>	Not Issued	166	06/15/1994	SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO

<u>08273915</u>	<u>5480816</u>	150	07/12/1994	METHOD OF FABRICATING A BIPOLAR TRANSISTOR HAVING A LINK BASE	ISHIDA, MASAHIRO
<u>08310526</u>	<u>5471085</u>	150	09/22/1994	SEMICONDUCTOR DEVICE WITH POLYCRYSTALLINE SILICON EMITTER CONDUCTIVE LAYER	ISHIDA, MASAHIRO
<u>08351144</u>	Not Issued	166	11/29/1994	STATIC SEMICONDUCTOR MEMORY DEVICE	ISHIDA, MASAHIRO
<u>08523963</u>	<u>5584750</u>	150	09/06/1995	POLISHING MACHINE WITH DETACHABLE SURFACE PLATE	ISHIDA, MASAHIRO
<u>08564520</u>	<u>5655954</u>	150	11/29/1995	POLISHING APPARATUS	ISHIDA, MASAHIRO
<u>08651244</u>	<u>5849119</u>	250	05/22/1996	PNEUMATIC TIRE INCLUDING ZIG-ZAG SUBGROOVES	ISHIDA, MASAHIRO
<u>08668526</u>	<u>5717240</u>	250	06/28/1996	STATIC SEMICONDUCTOR MEMORY DEVICE	ISHIDA, MASAHIRO
<u>08693497</u>	<u>5619056</u>	150	08/07/1996	SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>08810786</u>	<u>5841153</u>	150	03/05/1997	AN SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>08905048</u>	Not Issued	161	08/01/1997	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09056500</u>	<u>6069394</u>	150	04/08/1998	SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	ISHIDA, MASAHIRO
<u>09116245</u>	<u>5994719</u>	150	07/16/1998	A SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>09151756</u>	<u>6242806</u>	250	09/11/1998	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THEREOF	ISHIDA, MASAHIRO
<u>09194220</u>	<u>6661839</u>	150	11/20/1998	METHOD AND DEVICE FOR COMPRESSING AND EXPANDING DATA PATTERN	ISHIDA, MASAHIRO
<u>09227936</u>	<u>6180986</u>	150	01/11/1999	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE	ISHIDA, MASAHIRO

				SAME	
<u>09246458</u>	<u>6621860</u>	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<u>09251096</u>	<u>6291979</u>	150	02/16/1999	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT	ISHIDA, MASAHIRO
<u>09259328</u>	<u>6198139</u>	150	03/01/1999	A COMPLEMENTARY MOS DEVICE	ISHIDA, MASAHIRO
<u>09285648</u>	<u>6249534</u>	150	04/05/1999	NITRIDE SEMICONDUCTOR LASER DEVICE	ISHIDA, MASAHIRO
<u>09289960</u>	<u>6339014</u>	150	04/13/1999	METHOD FOR GROWING NITRIDE COMPOUND SEMICONDUCTOR	ISHIDA, MASAHIRO
<u>09317604</u>	<u>6218207</u>	150	05/25/1999	METHOD FOR GROWING NITRIDE SEMICONDUCTOR CRYSTALS, NITRIDE SEMICONDUCTOR DEVICE, AND METHOD FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09389024</u>	<u>6117700</u>	150	09/02/1999	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE HAVING GROUP III NITRIDE	ISHIDA, MASAHIRO
<u>09392376</u>	<u>6563140</u>	150	09/09/1999	SEMICONDUCTOR LIGHT EMITTING DEVICE	ISHIDA, MASAHIRO
<u>09395261</u>	<u>6617182</u>	150	09/14/1999	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09408280</u>	<u>6687629</u>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<u>09416523</u>	<u>6221050</u>	150	10/12/1999	SELF-RETAINING NEEDLE ASSEMBLY AND VALVE ELEMENT FOR USE THEREIN	ISHIDA, MASAHIRO
<u>09494321</u>	<u>6400129</u>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	ISHIDA, MASAHIRO
<u>09511371</u>	<u>6420197</u>	150	02/23/2000	Semiconductor device and method of fabricating the same	ISHIDA, MASAHIRO
<u>09512780</u>	<u>6423558</u>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC)	ISHIDA, MASAHIRO

				DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	
<a href="#">09532063</a>	<a href="#">6593159</a>	150	03/21/2000	SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	ISHIDA, MASAHIRO
<a href="#">09538135</a>	<a href="#">6460001</a>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	ISHIDA, MASAHIRO
<a href="#">09538186</a>	<a href="#">6735538</a>	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	ISHIDA, MASAHIRO
<a href="#">09546881</a>	<a href="#">6274518</a>	150	04/10/2000	Method for producing a group III nitride compound semiconductor substrate	ISHIDA, MASAHIRO
<a href="#">09623944</a>	Not Issued	161	09/12/2000	Pro-fragrance silicone polymer and compositions thereof	ISHIDA, MASAHIRO
<a href="#">09647908</a>	<a href="#">6795496</a>	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	ISHIDA, MASAHIRO
<a href="#">09650000</a>	<a href="#">6598004</a>	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	ISHIDA, MASAHIRO

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Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<a href="#">09663700</a>	<a href="#">6593765</a>	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">09680054</a>	<a href="#">6821805</a>	150	10/05/2000	SEMICONDUCTOR DEVICE, SEMICONDUCTOR SUBSTRATE, AND MANUFACTURE METHOD	ISHIDA, MASAHIRO
<a href="#">09699077</a>	<a href="#">6975978</a>	150	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">09702278</a>	Not Issued	160	10/30/2000	Method and apparatus for fault simulation of semiconductor integrated circuit	ISHIDA, MASAHIRO
<a href="#">09702695</a>	<a href="#">6440790</a>	250	11/01/2000	METHOD OF MAKING SEMICONDUCTOR DEVICE HAVING AN ISULATING FILM POSITIONED BETWEEN TWO SIMILARLY SHAPED CONDUCTIVE FILMS	ISHIDA, MASAHIRO
<a href="#">09703469</a>	<a href="#">6775321</a>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<a href="#">09722167</a>	<a href="#">6525523</a>	150	11/24/2000	JITTER MEASURMENT APPARATUS AND ITS METHOD	ISHIDA, MASAHIRO
<a href="#">09729424</a>	<a href="#">6653663</a>	150	12/05/2000	NITRIDE SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<a href="#">09748436</a>	<a href="#">6673702</a>	150	12/26/2000	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<a href="#">09758287</a>	<a href="#">6358770</a>	150	01/12/2001	METHOD FOR GROWING NITRIDE SEMICONDUCTOR	ISHIDA, MASAHIRO

				CRYSTALS, NITRIDE SEMICONDUCTOR DEVICE, AND METHOD FOR FABRICATING THE SAME	
<u>09790908</u>	<u>6566231</u>	150	02/23/2001	METHOD OF MANUFACTURING HIGH PERFORMANCE SEMICONDUCTOR DEVICE WITH REDUCED LATTICE DEFECTS IN THE ACTIVE REGION	ISHIDA, MASAHIRO
<u>09811153</u>	<u>6922439</u>	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
<u>09813923</u>	<u>7127018</u>	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	ISHIDA, MASAHIRO
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	ISHIDA, MASAHIRO
<u>09864218</u>	<u>6569238</u>	150	05/25/2001	APPARATUS AND METHOD FOR DEPOSITING SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
<u>09876389</u>	<u>7185254</u>	150	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09880976</u>	<u>6461882</u>	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09882290</u>	<u>7203229</u>	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
<u>09921885</u>	<u>6562644</u>	150	08/06/2001	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD	ISHIDA, MASAHIRO
<u>09980891</u>	<u>6801049</u>	150	12/03/2001	METHOD AND APPARATUS	ISHIDA,

				FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	MASAHIRO
<u>09986997</u>	Not Issued	161	11/13/2001	Method for fabricating semiconductor device having group III nitride	ISHIDA, MASAHIRO
<u>10032563</u>	<u>6864158</u>	150	01/02/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	ISHIDA, MASAHIRO
<u>10054844</u>	<u>6649494</u>	150	01/25/2002	MANUFACTURING METHOD OF COMPOUND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO
<u>10062512</u>	<u>6562701</u>	150	02/05/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	ISHIDA, MASAHIRO
<u>10100118</u>	<u>6589857</u>	150	03/19/2002	MANUFACTURING METHOD OF SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
<u>10118924</u>	<u>6723165</u>	150	04/10/2002	METHOD FOR FABRICATING GROUP III NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10134298</u>	<u>7054358</u>	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	ISHIDA, MASAHIRO
<u>10145144</u>	<u>6750158</u>	150	05/15/2002	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>10240182</u>	<u>6990417</u>	150	09/27/2002	Jitter estimating apparatus and estimating method	ISHIDA, MASAHIRO
<u>10249116</u>	<u>6815726</u>	150	03/17/2003	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	ISHIDA, MASAHIRO
<u>10265349</u>	Not Issued	161	10/04/2002	Measurement apparatus and measuring method	ISHIDA, MASAHIRO
<u>10405791</u>	<u>6773948</u>	150	04/02/2003	SEMICONDUCTOR LIGHT EMITTING DEVICE AND	ISHIDA, MASAHIRO

				METHOD FOR PRODUCING THE SAME	
<u>10413995</u>	<u>6905898</u>	150	04/16/2003	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD	ISHIDA, MASAHIRO
<u>10442301</u>	<u>6887770</u>	150	05/21/2003	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>10457362</u>	Not Issued	83	06/10/2003	Semiconductor wafer, semiconductor device, and methods for fabricating the same	ISHIDA, MASAHIRO
<u>10459438</u>	<u>6797991</u>	150	06/12/2003	NITRIDE SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>10531725</u>	Not Issued	71	04/18/2005	Pneumatic tire	ISHIDA, MASAHIRO
<u>10532069</u>	Not Issued	71	04/21/2005	Pneumatic tire	ISHIDA, MASAHIRO
<u>10711698</u>	Not Issued	161	09/30/2004	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>10737716</u>	<u>7136773</u>	150	12/16/2003	TESTING APPARATUS AND TESTING METHOD	ISHIDA, MASAHIRO
<u>10776926</u>	Not Issued	41	02/11/2004	Measuring apparatus and measuring method	ISHIDA, MASAHIRO
<u>10779904</u>	Not Issued	25	02/17/2004	Method and apparatus for defect analysis of semiconductor integrated circuit	ISHIDA, MASAHIRO
<u>10779905</u>	<u>6828815</u>	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>10824763</u>	Not Issued	30	04/14/2004	Testing apparatus and testing method	ISHIDA, MASAHIRO
<u>10862904</u>	Not Issued	41	06/07/2004	Wideband signal analyzing apparatus, wideband period jitter analyzing apparatus, and wideband skew analyzing apparatus	ISHIDA, MASAHIRO
<u>10896751</u>	Not	30	07/22/2004	Jitter measuring apparatus, jitter	ISHIDA,



	Issued			measuring method and PLL circuit	MASAHIRO
<u>10921913</u>	Not Issued	95	08/20/2004	MANUFACTURING METHOD FOR SEMICONDUCTOR DEVICE, SEMICONDUCTOR DEVICE AND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO

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## Inventor Name Search Result

Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<a href="#">10925870</a>	Not Issued	30	08/25/2004	Measurement instrument and measurement method	ISHIDA, MASAHIRO
<a href="#">10971716</a>	Not Issued	161	10/22/2004	Phase difference detecting apparatus	ISHIDA, MASAHIRO
<a href="#">11056330</a>	Not Issued	93	02/11/2005	TEST APPARATUS AND TEST METHOD FOR TESTING A DEVICE UNDER TEST	ISHIDA, MASAHIRO
<a href="#">11057707</a>	Not Issued	168	02/14/2005	Jitter measurement apparatus, jitter measurement method, and test apparatus	ISHIDA, MASAHIRO
<a href="#">11060212</a>	Not Issued	30	02/17/2005	Apparatus for measuring jitter, method of measuring jitter and computer-readable medium storing a program thereof	ISHIDA, MASAHIRO
<a href="#">11092804</a>	Not Issued	41	03/30/2005	Semiconductor substrate, method of manufacturing the semiconductor substrate, semiconductor device and pattern forming method	ISHIDA, MASAHIRO
<a href="#">11122262</a>	Not Issued	30	05/04/2005	Apparatus for measuring jitter and method of measuring jitter	ISHIDA, MASAHIRO
<a href="#">11137786</a>	Not Issued	30	05/25/2005	Apparatus for measuring jitter and method of measuring jitter	ISHIDA, MASAHIRO
<a href="#">11238821</a>	Not Issued	93	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">11238822</a>	<a href="#">7225378</a>	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">11239414</a>	<a href="#">7225377</a>	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING	ISHIDA, MASAHIRO

				SEMICONDUCTOR INTEGRATED CIRCUIT	
<u>11260665</u>	Not Issued	30	10/28/2005	Test apparatus, clock generator and electronic device	ISHIDA, MASAHIRO
<u>11266471</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus background of the invention	ISHIDA, MASAHIRO
<u>11266472</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus	ISHIDA, MASAHIRO
<u>11362536</u>	Not Issued	41	02/27/2006	Measuring apparatus, measuring method, testing apparatus, testing method, and electronics device	ISHIDA, MASAHIRO
<u>11371849</u>	Not Issued	25	03/10/2006	Calibration apparatus, calibration method, testing apparatus, and testing method	ISHIDA, MASAHIRO
<u>11371939</u>	Not Issued	25	03/10/2006	Electronic device, testing apparatus, and testing method	ISHIDA, MASAHIRO
<u>11378407</u>	Not Issued	30	03/17/2006	Jitter measurement apparatus, jitter measurement method, test apparatus and electronic device	ISHIDA, MASAHIRO
<u>11390340</u>	Not Issued	41	03/28/2006	Jitter amplifier, jitter amplification method, electronic device, testing apparatus, and testing method	ISHIDA, MASAHIRO
<u>11407136</u>	Not Issued	30	04/20/2006	Testing apparatus, testing method, jitter filtering circuit, and jitter filtering method	ISHIDA, MASAHIRO
<u>11407588</u>	Not Issued	41	04/20/2006	Calibration apparatus, calibration method, testing apparatus, and testing method	ISHIDA, MASAHIRO
<u>11535279</u>	Not Issued	30	09/26/2006	JITTER MEASUREMENT APPARATUS, JITTER MEASUREMENT METHOD, AND RECORDING MEDIUM	ISHIDA, MASAHIRO
<u>11535296</u>	Not Issued	25	09/26/2006	DELAY CIRCUIT, JITTER INJECTION CIRCUIT, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11570042</u>	Not Issued	19	01/01/0001	TIMING GENERATOR AND SEMICONDUCTOR TESTING APPARATUS	ISHIDA, MASAHIRO
<u>11581778</u>	Not Issued	30	10/16/2006	Jitter injection apparatus, jitter injection method, test apparatus, and communication chip	ISHIDA, MASAHIRO

<u>11582142</u>	Not Issued	30	10/17/2006	Calibration apparatus, calibration method, and testing apparatus	ISHIDA, MASAHIRO
<u>11582143</u>	Not Issued	25	10/17/2006	Calibration apparatus, calibration method, and testing apparatus	ISHIDA, MASAHIRO
<u>11585526</u>	Not Issued	41	10/23/2006	Apparatus for and method of measuring clock skew	ISHIDA, MASAHIRO
<u>11609950</u>	Not Issued	20	12/13/2006	OSCILLATOR CIRCUIT, PLL CIRCUIT, SEMICONDUCTOR CHIP, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616009</u>	Not Issued	20	12/25/2006	SIGNAL GENERATOR CIRCUIT, JITTER INJECTION CIRCUIT, SEMICONDUCTOR CHIP AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616010</u>	Not Issued	20	12/25/2006	JITTER AMPLIFIER CIRCUIT, SIGNAL GENERATION CIRCUIT, SEMICONDUCTOR CHIP, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616038</u>	Not Issued	16	12/26/2006	JITTER MEASUREMENT APPARATUS, ELECTRONIC DEVICE, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11745889</u>	Not Issued	19	01/01/0001	MANUFACTURING METHOD FOR SEMICONDUCTOR DEVICE, SEMICONDUCTOR DEVICE AND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO
<u>29055374</u>	<u>D390171</u>	150	06/05/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29060588</u>	<u>D392229</u>	150	10/01/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29060763</u>	<u>D387711</u>	150	10/07/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29107470</u>	<u>RE37306</u>	150	06/22/1999	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29150336</u>	<u>D467535</u>	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29150337</u>	<u>D460402</u>	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29211237</u>	<u>D512014</u>	150	08/13/2004	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29211238</u>	<u>D522962</u>	150	08/13/2004	AUTOMOBILE TIRE	ISHIDA, MASAHIRO

<a href="#">60277251</a>	Not Issued	159	03/20/2001	Apparatus and method for estimating probability of peak-to-peak value of clock skew	ISHIDA, MASAHIRO
<a href="#">60545697</a>	Not Issued	159	02/18/2004	Frequency-domain based method for measuring deterministic jitter	ISHIDA, MASAHIRO
<a href="#">60800391</a>	Not Issued	159	05/15/2006	Electrically-pumped (Ga,In,A1)N vertical-cavity surface-emitting laser	ISHIDA, MASAHIRO

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**Inventor Name Search Result**

Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>06162201</u>	Not Issued	161	06/23/1980	NOVEL SUBSTANCE THE69E AND PHARMACEUTICAL COMPOSITIONS CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>06352068</u>	<u>4543259</u>	150	02/24/1982	NOVEL SUBSTANCE TH69E AND IMMUNOPOTENTIATOR CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>06654132</u>	<u>4607216</u>	150	09/25/1984	APPARATUS FOR MEASUREMENT BY DIGITAL SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<u>06940058</u>	<u>4761634</u>	150	12/10/1986	AD CONVERTING DEVICE	YAMAGUCHI, TAKAHIRO
<u>07082231</u>	<u>4774454</u>	150	08/06/1987	DISTORTION MEASURING SYSTEM METHOD UTILIZING SIGNAL SUPPRESSION	YAMAGUCHI, TAKAHIRO
<u>07152339</u>	<u>5177254</u>	150	02/04/1988	METHOD FOR PRODUCING AN UNSATURATED GLYCOL DIESTER	YAMAGUCHI, TAKAHIRO
<u>07201684</u>	<u>4913955</u>	150	06/02/1988	EPOXY RESIN LAMINATE	YAMAGUCHI, TAKAHIRO
<u>07201685</u>	<u>4883708</u>	150	06/02/1988	A METAL FOIL COVERED LAMINATE	YAMAGUCHI, TAKAHIRO
<u>07251795</u>	<u>4914677</u>	150	10/03/1988	DIGITAL LOCK-IN AMPLIFIER	YAMAGUCHI, TAKAHIRO
<u>07271879</u>	<u>4885708</u>	150	11/16/1988	APPARATUS AND METHOD FOR MEASURING FREQUENCY RESPONSE FUNCTION	YAMAGUCHI, TAKAHIRO
<u>07401055</u>	Not Issued	168	08/31/1989	NUMERICAL CONTROL METHOD	YAMAGUCHI, TAKAHIRO
<u>07501139</u>	<u>5117368</u>	150	03/29/1990	CONTROL DEVICE FOR TAPPING	YAMAGUCHI, TAKAHIRO

<u>07770404</u>	<u>5198984</u>	150	10/03/1991	NUMERICAL CONTROL METHOD FOR CORRECTING MACHINE TOOL PATH ERRORS	YAMAGUCHI, TAKAHIRO
<u>08363223</u>	Not Issued	161	12/23/1994	SUBSTITUTED CYCLIC AMINE COMPOUND, PRODUCTION PROCESS THEREOF AND PHARMACEUTICAL COMPOSITION FOR CIRCULATORY ORGAN USE CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>08575062</u>	<u>5728835</u>	150	12/19/1995	SUBSTITUTED CYCLIC AMINE COMPOUND, PRODUCTION PROCESS THEREOF AND PHARMACEUTICAL COMPOSITION FOR CIRCULATORY ORGAN USE CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>08632131</u>	<u>5683753</u>	150	04/15/1996	METHOD OF PAINTING BUILDING BOARDS	YAMAGUCHI, TAKAHIRO
<u>08681502</u>	<u>5662968</u>	150	07/23/1996	METHOD OF PAINTING BUILDING BOARD BY SPRAY PAINTING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>08693598</u>	<u>5907316</u>	150	08/05/1996	METHOD OF AND APPARATUS FOR DISPLAYING HALFTONE IMAGES	YAMAGUCHI, TAKAHIRO
<u>08707032</u>	<u>6229316</u>	250	09/03/1996	MEASURING METHOD BY SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<u>08714409</u>	<u>6100939</u>	150	09/16/1996	TONE DISPLAY METHOD AND APPARATUS FOR DISPLAYING IMAGE SIGNAL	YAMAGUCHI, TAKAHIRO
<u>08883233</u>	<u>6529204</u>	150	06/26/1997	METHOD OF AND APPARATUS FOR DISPLAYING HALFTONE IMAGES	YAMAGUCHI, TAKAHIRO
<u>08944685</u>	<u>6147950</u>	150	10/07/1997	RECORDING AND REPRODUCING APPARATUS AND RECORDING AND REPRODUCING METHOD	YAMAGUCHI, TAKAHIRO
<u>09017881</u>	<u>6142581</u>	150	02/03/1998	HYDRAULIC CIRCUIT HAVING A ROTARY TYPE PUMP AND BRAKE APPARATUS FOR A VEHICLE PROVIDED WITH THE SAME	YAMAGUCHI, TAKAHIRO

<u>09063825</u>	<u>6013826</u>	250	04/22/1998	A METHOD FORMATION OF A CARBON-CARBON BOND	YAMAGUCHI, TAKAHIRO
<u>09077658</u>	<u>6018504</u>	150	09/30/1998	RECORDING DEVICE CAPABLE OF RECORDING BROADCAST SIGNALS AT A DESIRED TIME	YAMAGUCHI, TAKAHIRO
<u>09157272</u>	<u>6326909</u>	150	09/18/1998	EVALUATION SYSTEM FOR ANALOG-DIGITAL OR DIGITAL-ANALOG CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09165267</u>	Not Issued	161	10/01/1998	AUTOMATIC REMOTE ELECTRONIC INSTRUMENT CONNECTING SYSTEM	YAMAGUCHI, TAKAHIRO
<u>09166269</u>	Not Issued	161	10/05/1998	MEASURING SYSTEM	YAMAGUCHI, TAKAHIRO
<u>09166297</u>	<u>6418391</u>	150	10/05/1998	TESTING SYSTEM FOR PERFORMING AN OPERATION OF AN APPLICATION WHICH CONTROLS TESTING EQUIPMENT FOR TESTING A DEVICE UNDER TEST AND METHOD FOR CONTROLLING THE SAME	YAMAGUCHI, TAKAHIRO
<u>09166698</u>	Not Issued	161	10/05/1998	GUI PROCESSING SYSTEM FOR PERFORMING AN OPERATION OF AN APPLICATION WHICH CONTROLS TESTING EQUIPMENT	YAMAGUCHI, TAKAHIRO
<u>09170052</u>	<u>6270169</u>	150	10/13/1998	ROTARY PUMP AND BRAKING DEVICE USING SAME	YAMAGUCHI, TAKAHIRO
<u>09183644</u>	<u>6177894</u>	150	10/30/1998	EVALUATION SYSTEM AND METHOD FOR AD CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09194220</u>	<u>6661839</u>	150	11/20/1998	METHOD AND DEVICE FOR COMPRESSING AND EXPANDING DATA PATTERN	YAMAGUCHI, TAKAHIRO
<u>09246458</u>	<u>6621860</u>	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
<u>09248110</u>	<u>6191571</u>	250	02/11/1999	MEASURING METHOD BY SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<u>09251096</u>	<u>6291979</u>	150	02/16/1999	APPARATUS FOR AND	YAMAGUCHI,



				METHOD OF DETECTING A DELAY FAULT	TAKAHIRO
<u>09299798</u>	<u>6442733</u>	150	04/26/1999	FAILURE ANALYZING METHOD AND APPARATUS	YAMAGUCHI, TAKAHIRO
<u>09408280</u>	<u>6687629</u>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
<u>09412315</u>	<u>6273527</u>	150	10/05/1999	ROTARY PUMP WITH BETTER FLUID SEALING STRUCTURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>09413818</u>	<u>6584236</u>	150	10/07/1999	IMAGE PROCESSING APPARATUS AND METHOD FOR IMAGE PROCESSING	YAMAGUCHI, TAKAHIRO
<u>09494321</u>	<u>6400129</u>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09512780</u>	<u>6423558</u>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	YAMAGUCHI, TAKAHIRO
<u>09528720</u>	Not Issued	161	03/20/2000	Measuring method by spectrum analyzer	YAMAGUCHI, TAKAHIRO
<u>09538135</u>	<u>6460001</u>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	YAMAGUCHI, TAKAHIRO
<u>09538186</u>	<u>6735538</u>	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	YAMAGUCHI, TAKAHIRO
<u>09634734</u>	<u>6333766</u>	150	08/08/2000	Tone display method and apparatus for displaying image signal	YAMAGUCHI, TAKAHIRO
<u>09647908</u>	<u>6795496</u>	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	YAMAGUCHI, TAKAHIRO
<u>09650000</u>	<u>6598004</u>	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
<u>09663700</u>	<u>6593765</u>	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09694680</u>	<u>6474751</u>	150	10/24/2000	HYDRAULIC CIRCUIT	YAMAGUCHI,

				HAVING A ROTARY TYPE PUMP AND BRAKE APPARATUS FOR A VEHICLE PROVIDED WITH THE SAME	TAKAHIRO
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## Inventor Name Search Result

Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>09697294</u>	<u>6478477</u>	150	10/27/2000	PLANAR PACKAGED OPTICAL MODULE HAVING 1ST AND 2ND ADHESIVES WITH DIFFERENT GLASS-TRANSITION TEMPERATURES	YAMAGUCHI, TAKAHIRO
<u>09699077</u>	<u>6975978</u>	150	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09702278</u>	Not Issued	160	10/30/2000	Method and apparatus for fault simulation of semiconductor integrated circuit	YAMAGUCHI, TAKAHIRO
<u>09703469</u>	<u>6775321</u>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
<u>09722167</u>	<u>6525523</u>	150	11/24/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
<u>09811153</u>	<u>6922439</u>	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
<u>09813923</u>	<u>7127018</u>	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	YAMAGUCHI, TAKAHIRO
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	YAMAGUCHI, TAKAHIRO
<u>09835824</u>	<u>7035959</u>	150	04/17/2001	ADAPTER FOR CONTROLLING A MEASURING DEVICE, A MEASURING DEVICE, A	YAMAGUCHI, TAKAHIRO

				CONTROLLER FOR A MEASURING DEVICE, A METHOD FOR PROCESSING MEASUREMENT AND A RECORDING MEDIUM	
<u>09876389</u>	<u>7185254</u>	150	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09880976</u>	<u>6461882</u>	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09882290</u>	<u>7203229</u>	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
<u>09897024</u>	<u>6474752</u>	150	07/03/2001	ROTARY PUMP AND BRAKING DEVICE USING SAME	YAMAGUCHI, TAKAHIRO
<u>09905882</u>	<u>7031595</u>	150	07/17/2001	DISK REPRODUCING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>09925230</u>	<u>6476742</u>	150	08/08/2001	EVALUATION SYSTEM FOR ANALOG-DIGITAL OR DIGITAL-ANALOG CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09980891</u>	<u>6801049</u>	150	12/03/2001	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09995402</u>	Not Issued	161	11/26/2001	Automatic remote electronic instrument connecting system and method	YAMAGUCHI, TAKAHIRO
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	YAMAGUCHI, TAKAHIRO
<u>10033533</u>	Not Issued	161	10/25/2001	GUI processing system for performing an operation of an application which controls testing equipment	YAMAGUCHI, TAKAHIRO
<u>10053882</u>	<u>6715847</u>	150	01/24/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10082307</u>	Not	164	02/26/2002	PLANAR PACKAGED	YAMAGUCHI,

	Issued			OPTICAL MODULE AND TRANSMISSION SUBSTRATE USING PLANAR PACKAGE OPTICAL MODULE	TAKAHIRO
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	YAMAGUCHI, TAKAHIRO
<u>10134298</u>	<u>7054358</u>	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	YAMAGUCHI, TAKAHIRO
<u>10205592</u>	Not Issued	71	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	YAMAGUCHI, TAKAHIRO
<u>10214443</u>	<u>6749272</u>	150	08/08/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10214472</u>	<u>7193728</u>	150	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	YAMAGUCHI, TAKAHIRO
<u>10240182</u>	<u>6990417</u>	150	09/27/2002	Jitter estimating apparatus and estimating method	YAMAGUCHI, TAKAHIRO
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	YAMAGUCHI, TAKAHIRO
<u>10265349</u>	Not Issued	161	10/04/2002	Measurement apparatus and measuring method	YAMAGUCHI, TAKAHIRO
<u>10279996</u>	<u>6783193</u>	150	10/25/2002	ROTARY PUMP AND BRAKING APPARATUS USING ROTARY PUMP	YAMAGUCHI, TAKAHIRO
<u>10298841</u>	Not Issued	41	11/18/2002	Relay apparatus and relay method suitable for performing communication to ensure quality of service	YAMAGUCHI, TAKAHIRO
<u>10369199</u>	<u>7144091</u>	150	02/20/2003	BRAKE APPARATUS WITH ORIFICES FOR RESTRICTING BRAKE FLUID PRESSURE PULSATION	YAMAGUCHI, TAKAHIRO
<u>10382993</u>	<u>7020053</u>	150	03/07/2003	OPTICAL DISC APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10453623</u>	<u>6905321</u>	150	06/04/2003	ROTARY PUMP FOR BRAKING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10463471</u>	Not	161	06/18/2003	Optical transmitter/receiver	YAMAGUCHI,

	Issued			module	TAKAHIRO
<u>10521942</u>	Not Issued	30	01/21/2005	Driver of compressor and refrigerator	YAMAGUCHI, TAKAHIRO
<u>10522217</u>	<u>7219522</u>	150	01/24/2005	OVAL CROSS SECTION METAL TUBE PRODUCING DEVICE AND PRODUCING METHOD	YAMAGUCHI, TAKAHIRO
<u>10546917</u>	Not Issued	30	08/25/2005	Association control apparatus, association control method and service association system	YAMAGUCHI, TAKAHIRO
<u>10553469</u>	Not Issued	30	10/17/2005	Electronic watermark-containing moving picture transmission system, electronic watermark-containing moving picture transmission method, information processing device, communication control device, electronic watermark-containing moving picture processing program, and storage medium containing electronic watermark-containing	YAMAGUCHI, TAKAHIRO
<u>10699345</u>	<u>7164642</u>	150	11/03/2003	OPTICAL DISK REPRODUCING APPARATUS AND METHOD FOR CONTROLLING SPINDLE MOTOR	YAMAGUCHI, TAKAHIRO
<u>10713280</u>	<u>7049608</u>	150	11/15/2003	POSITION DETECTION APPARATUS, POSITION DETECTION METHOD, ELECTRONIC PART CARRYING APPARATUS, AND ELECTRONIC BEAM EXPOSURE APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10737716</u>	<u>7136773</u>	150	12/16/2003	TESTING APPARATUS AND TESTING METHOD	YAMAGUCHI, TAKAHIRO
<u>10776926</u>	Not Issued	41	02/11/2004	Measuring apparatus and measuring method	YAMAGUCHI, TAKAHIRO
<u>10779904</u>	Not Issued	25	02/17/2004	Method and apparatus for defect analysis of semiconductor integrated circuit	YAMAGUCHI, TAKAHIRO
<u>10779905</u>	<u>6828815</u>	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>10824763</u>	Not	30	04/14/2004	Testing apparatus and testing	YAMAGUCHI,

	Issued			method	TAKAHIRO
<a href="#"><u>10862904</u></a>	Not Issued	41	06/07/2004	Wideband signal analyzing apparatus, wideband period jitter analyzing apparatus, and wideband skew analyzing apparatus	YAMAGUCHI, TAKAHIRO
<a href="#"><u>10896751</u></a>	Not Issued	30	07/22/2004	Jitter measuring apparatus, jitter measuring method and PLL circuit	YAMAGUCHI, TAKAHIRO
<a href="#"><u>10925870</u></a>	Not Issued	30	08/25/2004	Measurement instrument and measurement method	YAMAGUCHI, TAKAHIRO
<a href="#"><u>10971716</u></a>	Not Issued	161	10/22/2004	Phase difference detecting apparatus	YAMAGUCHI, TAKAHIRO

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**Inventor Name Search Result**

Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<a href="#">11056330</a>	Not Issued	93	02/11/2005	TEST APPARATUS AND TEST METHOD FOR TESTING A DEVICE UNDER TEST	YAMAGUCHI, TAKAHIRO
<a href="#">11057707</a>	Not Issued	168	02/14/2005	Jitter measurement apparatus, jitter measurement method, and test apparatus	YAMAGUCHI, TAKAHIRO
<a href="#">11060212</a>	Not Issued	30	02/17/2005	Apparatus for measuring jitter, method of measuring jitter and computer-readable medium storing a program thereof	YAMAGUCHI, TAKAHIRO
<a href="#">11101350</a>	<a href="#">7167772</a>	150	04/07/2005	MACHINING TIME CALCULATING APPARATUS	YAMAGUCHI, TAKAHIRO
<a href="#">11122262</a>	Not Issued	30	05/04/2005	Apparatus for measuring jitter and method of measuring jitter	YAMAGUCHI, TAKAHIRO
<a href="#">11137786</a>	Not Issued	30	05/25/2005	Apparatus for measuring jitter and method of measuring jitter	YAMAGUCHI, TAKAHIRO
<a href="#">11182018</a>	<a href="#">7193434</a>	150	07/15/2005	SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<a href="#">11182026</a>	Not Issued	41	07/15/2005	Semiconductor integrated circuit and manufacturing method of the same	YAMAGUCHI, TAKAHIRO
<a href="#">11238821</a>	Not Issued	93	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<a href="#">11238822</a>	<a href="#">7225378</a>	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<a href="#">11239414</a>	<a href="#">7225377</a>	150	09/28/2005	GENERATING TEST PATTERNS USED IN	YAMAGUCHI, TAKAHIRO



				TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	
<u>11259059</u>	Not Issued	30	10/27/2005	Rotary pump for braking device	YAMAGUCHI, TAKAHIRO
<u>11260665</u>	Not Issued	30	10/28/2005	Test apparatus, clock generator and electronic device	YAMAGUCHI, TAKAHIRO
<u>11266471</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus background of the invention	YAMAGUCHI, TAKAHIRO
<u>11266472</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus	YAMAGUCHI, TAKAHIRO
<u>11334752</u>	Not Issued	30	01/19/2006	Position detection apparatus, position detection method, testing apparatus, and camera module manufacturing apparatus	YAMAGUCHI, TAKAHIRO
<u>11337565</u>	Not Issued	30	01/24/2006	Electronic device and display control method	YAMAGUCHI, TAKAHIRO
<u>11340870</u>	Not Issued	30	01/27/2006	Residue number system arithmetic operating system, scaling operator, scaling operation method and program and recording medium of the same	YAMAGUCHI, TAKAHIRO
<u>11362536</u>	Not Issued	41	02/27/2006	Measuring apparatus, measuring method, testing apparatus, testing method, and electronics device	YAMAGUCHI, TAKAHIRO
<u>11371849</u>	Not Issued	25	03/10/2006	Calibration apparatus, calibration method, testing apparatus, and testing method	YAMAGUCHI, TAKAHIRO
<u>11371939</u>	Not Issued	25	03/10/2006	Electronic device, testing apparatus, and testing method	YAMAGUCHI, TAKAHIRO
<u>11378407</u>	Not Issued	30	03/17/2006	Jitter measurement apparatus, jitter measurement method, test apparatus and electronic device	YAMAGUCHI, TAKAHIRO
<u>11390340</u>	Not Issued	41	03/28/2006	Jitter amplifier, jitter amplification method, electronic device, testing apparatus, and testing method	YAMAGUCHI, TAKAHIRO
<u>11407136</u>	Not Issued	30	04/20/2006	Testing apparatus, testing method, jitter filtering circuit, and jitter filtering method	YAMAGUCHI, TAKAHIRO
<u>11463644</u>	Not	19	08/10/2006	PROBABILITY DENSITY	YAMAGUCHI,

	Issued			FUNCTION SEPARATING APPARATUS, PROBABILITY DENSITY FUNCTION SEPARATING METHOD, TESTING APPARATUS, BIT ERROR RATE MEASURING APPARATUS, ELECTRONIC DEVICE, AND PROGRAM	TAKAHIRO
<u>11475056</u>	Not Issued	25	06/27/2006	Spray nozzle	YAMAGUCHI, TAKAHIRO
<u>11535279</u>	Not Issued	30	09/26/2006	JITTER MEASUREMENT APPARATUS, JITTER MEASUREMENT METHOD, AND RECORDING MEDIUM	YAMAGUCHI, TAKAHIRO
<u>11585526</u>	Not Issued	41	10/23/2006	Apparatus for and method of measuring clock skew	YAMAGUCHI, TAKAHIRO
<u>11589237</u>	Not Issued	25	10/30/2006	Vehicular brake device	YAMAGUCHI, TAKAHIRO
<u>11668098</u>	Not Issued	20	01/29/2007	OPTICAL PICKUP	YAMAGUCHI, TAKAHIRO
<u>11688877</u>	Not Issued	19	03/21/2007	PROBABILITY DENSITY FUNCTION SEPARATING APPARATUS, PROBABILITY DENSITY FUNCTION SEPARATING METHOD, NOISE SEPARATING APPARATUS, NOISE SEPARATING METHOD, TESTING APPARATUS, TESTING METHOD, CALCULATING APPARATUS, CALCULATING METHOD, PROGRAM, AND RECORDING MEDIUM	YAMAGUCHI, TAKAHIRO
<u>11727589</u>	Not Issued	25	03/27/2007	Pump device	YAMAGUCHI, TAKAHIRO
<u>60545697</u>	Not Issued	159	02/18/2004	Frequency-domain based method for measuring deterministic jitter	YAMAGUCHI, TAKAHIRO
<u>60783820</u>	Not Issued	159	03/21/2006	Probability density function separating apparatus, probability density function separating method, noise separating apparatus, noise separating method, testing apparatus, testing method, calculating apparatus,	YAMAGUCHI, TAKAHIRO

				calculating method, program, and recording medium	
<u>60894458</u>	Not Issued	20	03/13/2007	TEST APPARATUS.	YAMAGUCHI, TAKAHIRO

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**PALM INTRANET**

## Inventor Name Search Result

Your Search was:

Last Name = SOMA

First Name = MANI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<a href="#">09043659</a>	<a href="#">5980246</a>	150	03/24/1998	ORTHODONTICS HEADGEAR COMPLIANCE MONITOR	SOMA, MANI
<a href="#">09246458</a>	<a href="#">6621860</a>	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<a href="#">09251096</a>	<a href="#">6291979</a>	150	02/16/1999	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT	SOMA, MANI
<a href="#">09408280</a>	<a href="#">6687629</a>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<a href="#">09494321</a>	<a href="#">6400129</a>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	SOMA, MANI
<a href="#">09512780</a>	<a href="#">6423558</a>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	SOMA, MANI
<a href="#">09538135</a>	<a href="#">6460001</a>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	SOMA, MANI
<a href="#">09538186</a>	<a href="#">6735538</a>	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	SOMA, MANI
<a href="#">09647908</a>	<a href="#">6795496</a>	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	SOMA, MANI
<a href="#">09650000</a>	<a href="#">6598004</a>	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	SOMA, MANI
<a href="#">09669487</a>	<a href="#">6885700</a>	150	09/25/2000	CHARGE-BASED FREQUENCY	SOMA, MANI

				MEASUREMENT BIST	
<u>09703469</u>	<u>6775321</u>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<u>09722167</u>	<u>6525523</u>	150	11/24/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	SOMA, MANI
<u>09811153</u>	<u>6922439</u>	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>09813923</u>	<u>7127018</u>	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	SOMA, MANI
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	SOMA, MANI
<u>09882290</u>	<u>7203229</u>	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	SOMA, MANI
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	SOMA, MANI
<u>10134298</u>	<u>7054358</u>	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	SOMA, MANI
<u>10205592</u>	Not Issued	71	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	SOMA, MANI
<u>10214472</u>	<u>7193728</u>	150	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	SOMA, MANI
<u>10240182</u>	<u>6990417</u>	150	09/27/2002	Jitter estimating apparatus and estimating method	SOMA, MANI
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	SOMA, MANI
<u>10265349</u>	Not Issued	161	10/04/2002	Measurement apparatus and measuring method	SOMA, MANI
<u>10665970</u>	Not Issued	41	09/18/2003	Characterization of radio frequency (RF) signals using wavelet-based parameter	SOMA, MANI

				extraction	
<u>10737716</u>	<u>7136773</u>	150	12/16/2003	TESTING APPARATUS AND TESTING METHOD	SOMA, MANI
<u>10776926</u>	Not Issued	41	02/11/2004	Measuring apparatus and measuring method	SOMA, MANI
<u>10824763</u>	Not Issued	30	04/14/2004	Testing apparatus and testing method	SOMA, MANI
<u>10862904</u>	Not Issued	41	06/07/2004	Wideband signal analyzing apparatus, wideband period jitter analyzing apparatus, and wideband skew analyzing apparatus	SOMA, MANI
<u>10896751</u>	Not Issued	30	07/22/2004	Jitter measuring apparatus, jitter measuring method and PLL circuit	SOMA, MANI
<u>10925870</u>	Not Issued	30	08/25/2004	Measurement instrument and measurement method	SOMA, MANI
<u>10971716</u>	Not Issued	161	10/22/2004	Phase difference detecting apparatus	SOMA, MANI
<u>11056330</u>	Not Issued	93	02/11/2005	TEST APPARATUS AND TEST METHOD FOR TESTING A DEVICE UNDER TEST	SOMA, MANI
<u>11057707</u>	Not Issued	168	02/14/2005	Jitter measurement apparatus, jitter measurement method, and test apparatus	SOMA, MANI
<u>11060212</u>	Not Issued	30	02/17/2005	Apparatus for measuring jitter, method of measuring jitter and computer-readable medium storing a program thereof	SOMA, MANI
<u>11122262</u>	Not Issued	30	05/04/2005	Apparatus for measuring jitter and method of measuring jitter	SOMA, MANI
<u>11137786</u>	Not Issued	30	05/25/2005	Apparatus for measuring jitter and method of measuring jitter	SOMA, MANI
<u>11260665</u>	Not Issued	30	10/28/2005	Test apparatus, clock generator and electronic device	SOMA, MANI
<u>11378407</u>	Not Issued	30	03/17/2006	Jitter measurement apparatus, jitter measurement method, test apparatus and electronic device	SOMA, MANI
<u>11585526</u>	Not Issued	41	10/23/2006	Apparatus for and method of measuring clock skew	SOMA, MANI
<u>60004382</u>	Not Issued	159	09/27/1995	ORTHODONTICS HEADGEAR COMPLIANCE MONITOR	SOMA, MANI
<u>60155634</u>	Not Issued	159	09/23/1999	CHARGE-BASED FREQUENCY MEASUREMENT BIST FOR	SOMA, MANI

				PLL	
<a href="#">60277251</a>	Not Issued	159	03/20/2001	Apparatus and method for estimating probability of peak-to-peak value of clock skew	SOMA, MANI
<a href="#">60415975</a>	Not Issued	159	10/04/2002	Timing parameter extraction methods using the Haar wavelet	SOMA, MANI
<a href="#">60416033</a>	Not Issued	159	10/04/2002	Frequency and phase measurements using the morlet transform	SOMA, MANI
<a href="#">60529948</a>	Not Issued	159	12/15/2003	Method to measure RF transmitter bandwidth in time domain	SOMA, MANI
<a href="#">60545697</a>	Not Issued	159	02/18/2004	Frequency-domain based method for measuring deterministic jitter	SOMA, MANI

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